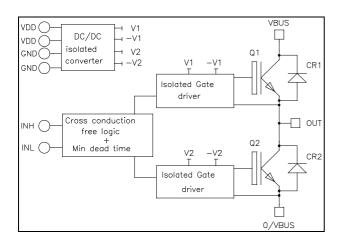
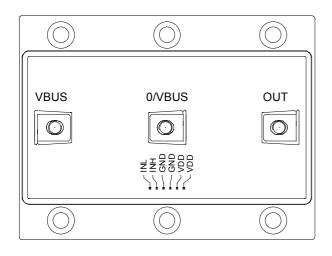


Phase leg Intelligent Power Module





# APTLGF300A1208G

## $V_{CES} = 1200V$ $I_{C} = 300A$ @ Tc = 80°C

#### Application

- Motor control
- Uninterruptible Power Supplies
- Switched Mode Power Supplies
- Amplifier
- Features
  - Non Punch Through (NPT) FAST IGBT
    - Low voltage drop
    - Low tail current
    - Soft recovery parallel diodes
    - Low diode VF
    - Low leakage current
    - RBSOA & SCSOA rated
  - Integrated Fail Safe IGBT Protection (Driver)
    - Top Bottom input signals Interlock
    - Isolated DC/DC Converter
  - · Low stray inductance
  - M5 power connectors
  - High level of integration

#### Benefits

- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Very high noise immunity (common mode rejection > 25kV/µs)
- Galvanic Isolation: 3750V for the optocoupler 2500V for the transformer
- 5V logic level with Schmitt-trigger Input
- Single  $V_{DD}$ =5V supply required
- Secondary auxiliary power supplies internally generated (15V, -6V)
- Optocoupler qualified to AEC-Q100 test guidelines
- RoHS compliant

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



## All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

#### 1. Inverter Power Module

### Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		1200	V
т	Continuous Collector Current	$T_C = 25^{\circ}C$	400	
I <sub>C</sub>	Continuous Conector Current	$T_C = 80^{\circ}C$	300	Α
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	600	
PD	Maximum Power Dissipation	$T_C = 25^{\circ}C$	1780	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125^{\circ}C$	600A @ 1200V	

#### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_j = 25^{\circ}C$			500	μΑ
		$V_{CE} = 1200V$	$T_{j} = 125^{\circ}C$			750	
V <sub>CE(sat)</sub>	Collector Emitter Saturation Voltage	$V_{DD} = V_{IN} = 5V$	$T_j = 25^{\circ}C$		3.2	3.9	V
		$I_{\rm C} = 300 {\rm A}$	$T_{j} = 125^{\circ}C$		4		v

### **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		21		
C <sub>oes</sub>	Output Capacitance	$V_{CE} = 25V$		2.9		nF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1 MHz		1.52		
T <sub>r</sub>	Rise Time	Inductive Switching (25°C) V = V = 5V		50		ns
$T_{f}$	Fall Time	$V_{DD} = V_{IN} = 5V$ $V_{Bus} = 600V$ ; $I_C = 300A$		30		115
T <sub>r</sub>	Rise Time	Inductive Switching (125°C)		60		ng
$T_{\rm f}$	Fall Time	$V_{DD} = V_{IN} = 5V$		40		ns
Eon	Turn-on Switching Energy	$V_{Bus} = 600V$ $I_{C} = 300A$		25		<b>T</b>
$E_{\text{off}}$	Turn-off Switching Energy			15		mJ
I <sub>sc</sub>	Short Circuit data	$V_{DD} = V_{IN} = 5V; V_{Bus} = 900V$ $t_p \le 10\mu s; T_1 = 125^{\circ}C$		1800		А
R <sub>thJC</sub>	Junction to Case thermal resistance				0.07	°C/W



# APTLGF300A1208G

#### **Reverse diode ratings and characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			1200			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1200V	$T_i = 25^{\circ}C$ $T_i = 125^{\circ}C$			250 500	μA
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		300		Α
V	F Diode Forward Voltage $I_F = 300A$	1 200 4	$T_i = 25^{\circ}C$		2.1		V
$V_{\rm F}$		$T_{i} = 125^{\circ}C$		1.9		v	
t	Reverse Recovery Time		$T_j = 25^{\circ}C$		120		ns
t <sub>rr</sub>		$T_{j} = 125^{\circ}C$		210		115	
Q <sub>rr</sub>	Reverse Recovery Charge	$V_{\rm R} = 600 V$	$T_j = 25^{\circ}C$		22		μC
Qrr	Reverse Recovery Charge		$T_{i} = 125^{\circ}C$		56		μΟ
Г			$T_i = 25^{\circ}C$		7.2		<b>T</b>
Err	Reverse Recovery Energy		$T_{j} = 125^{\circ}C$		18		mJ
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.12	°C/W

#### 2. Driver

### Absolute maximum ratings

Symbol		Parameter	Max ratings	Unit
$V_{DD}$	Supply Voltage		5.5	V
V <sub>INi</sub>	Input signal voltage i=L, H		5.5	v
T	Maximum Supply current $\frac{V_{INi} = 0V, i = L \& H}{V_{DD} = 5V, V_{INH} = /V_{INL}; F_{out} = 50 \text{kHz}}$	$V_{INi} = 0V, i = L \& H$	0.35	•
I <sub>VDDmax</sub>		2	A	
$\mathbf{f}_{max}$	Maximum Switching Frequen	cy	50	kHz

### **Driver Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V <sub>DD</sub>	Operating Supply Voltage		4.5	5	5.5	V
V <sub>INi(max)</sub>	Maximum Input Voltage		-0.5	5	5.5	
V <sub>INi (th+)</sub>	Positive Going Threshold Voltage	i = L, H		3.2		V
V <sub>INi(th-)</sub>	Negative Going Threshold Voltage	1 2,11		1		
R <sub>INi</sub>	Input Resistance *	1		1		kΩ
T <sub>d(on)</sub>	Turn On delay time	Driver + IGBT		1100 <sup>0</sup>		
D <sub>T</sub>	Built in dead time			600		ns
T <sub>d(off)</sub>	Turn Off delay time	Driver + IGBT		750		
PWD	Pulse Width Distortion				300	
PDD	Propagation Delay Difference between any two driver	T <sub>d(on)</sub> - T <sub>d(off)</sub>	-350		350	ns
V <sub>ISOL</sub>	Primary to Secondary Isolation		2500			$V_{RMS}$

\* Low impedance guarantees good noise immunity.

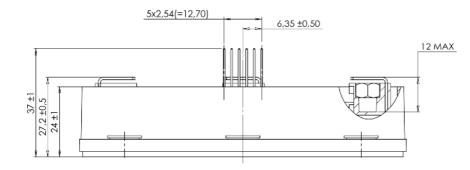
• Including built in dead time.

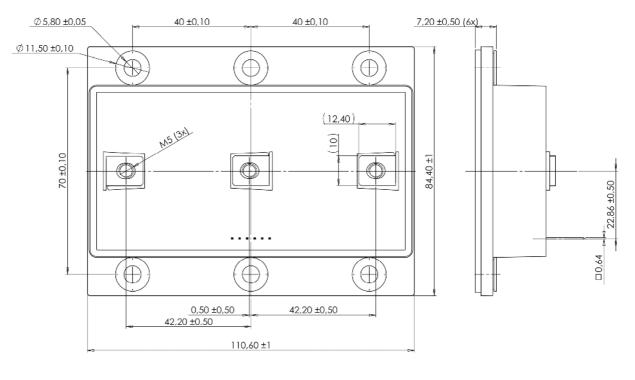


### 3. Package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit		
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =	1 min, 50/60Hz		4000			V		
T <sub>J</sub>	Operating junction temperature range -40 150				150				
T <sub>OP</sub>	Operating Ambient Temperature			-40		85	°C		
T <sub>STG</sub>	Storage Temperature Range			-40		100			
T <sub>C</sub>	Operating Case Temperature		-40		100				
Torqua	Mounting torque To heatsink M5   For terminals M5	To heatsink	M5	2		4.7	N.m		
Torque		M5	2		4	19.111			
Wt	Package Weight				550		g		

### 4. LP8 Package outline (dimensions in mm)



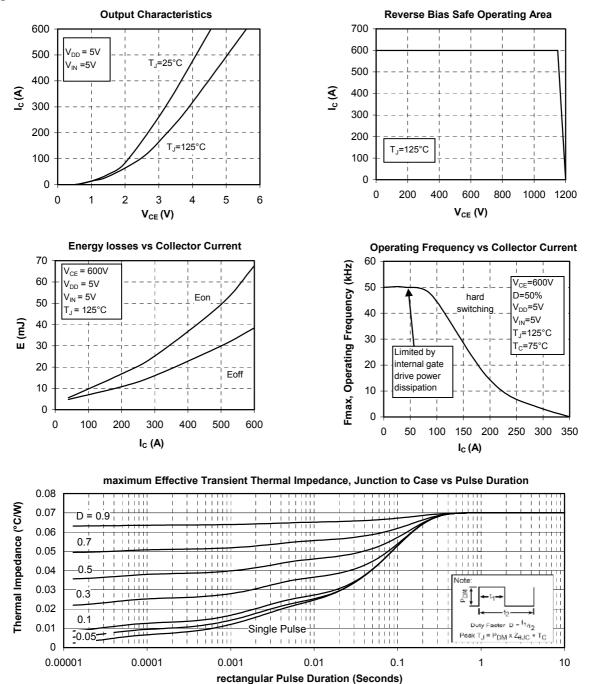


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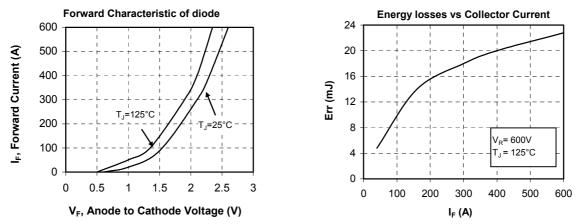
#### **Typical IGBT Performance Curve**

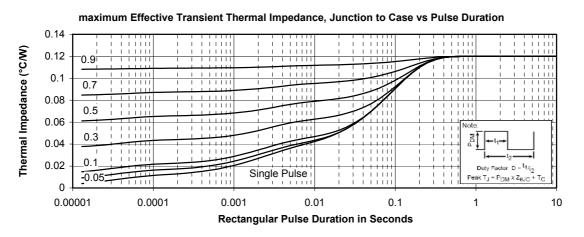


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#### **Typical diode Performance Curve**





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